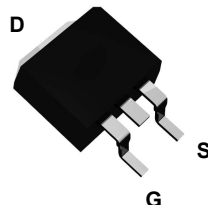
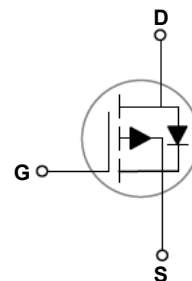


Main Product Characteristics

$V_{(BR)DSS}$	-100V
$R_{DS(ON)}$	45mΩ
I_D	-30A



TO-252 (DPAK)



Schematic Diagram

Features and Benefits

- Advanced MOSFET process technology
- Ideal for high efficiency switched mode power supplies
- Low on-resistance with low gate charge
- Fast switching and reverse body recovery



Description

The SSFD0959 utilizes the latest techniques to achieve high cell density and low on-resistance. These features make this device extremely efficient and reliable for use in high efficiency switch mode power supply and a wide variety of other applications.

Absolute Maximum Ratings ($T_C=25^{\circ}\text{C}$ unless otherwise specified)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	-100	V
Gate-Source Voltage	V_{GS}	±20	V
Drain Current – Continuous ($T_C=25^{\circ}\text{C}$)	I_D	-30	A
Drain Current – Continuous ($T_C=100^{\circ}\text{C}$)		-19	A
Drain Current – Pulsed ¹	I_{DM}	-120	A
Single Pulse Avalanche Energy ²	E_{AS}	180	mJ
Single Pulse Avalanche Current ²	I_{AS}	-60	A
Power Dissipation ($T_C=25^{\circ}\text{C}$)	P_D	102	W
Power Dissipation – Derate above 25°C		0.82	W/°C
Storage Temperature Range	T_{STG}	-55 to +150	°C
Operating Junction Temperature Range	T_J	-55 to +150	°C

Thermal Characteristics

Parameter	Symbol	Typ.	Max.	Unit
Thermal Resistance Junction to Case	$R_{\theta JC}$	---	1.22	°C/W
Thermal Resistance Junction to Ambient	$R_{\theta JA}$	---	62	°C/W

Electrical Characteristics ($T_J=25^{\circ}\text{C}$ unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=-250\mu A$	-100	---	---	V
Drain-Source Leakage Current	I_{DSS}	$V_{DS}=-100V, V_{GS}=0V, T_J=25^{\circ}\text{C}$	---	---	-1	μA
		$V_{DS}=-80V, V_{GS}=0V, T_J=85^{\circ}\text{C}$	---	---	-10	μA
Gate-Source Leakage Current	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$	---	---	± 100	nA
On Characteristics						
Static Drain-Source On-Resistance	$R_{DS(ON)}$	$V_{GS}=-10V, I_D=-15A$	---	36	45	m Ω
		$V_{GS}=-4.5V, I_D=-10A$	---	40	55	m Ω
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS}=V_{DS}, I_D=-250\mu A$	-1.2	---	-2.5	V
Forward Transconductance	g_{fs}	$V_{DS}=-10V, I_D=-5A$	---	22	---	S
Dynamic and Switching Characteristics						
Total Gate Charge ^{3, 4}	Q_g	$V_{DS}=-50V, V_{GS}=-10V, I_D=-10A$	---	98	150	nC
Gate-Source Charge ^{3, 4}	Q_{gs}		---	16.2	30	
Gate-Drain Charge ^{3, 4}	Q_{gd}		---	13.8	26	
Turn-On Delay Time ^{3, 4}	$T_{d(on)}$	$V_{DD}=-50V, V_{GS}=-10V, R_G=25\Omega, I_D=-5A$	---	58	105	nS
Rise Time ^{3, 4}	T_r		---	24	50	
Turn-Off Delay Time ^{3, 4}	$T_{d(off)}$		---	215	450	
Fall Time ^{3, 4}	T_f		---	94	180	
Input Capacitance	C_{iss}	$V_{DS}=-25V, V_{GS}=0V, F=1\text{MHz}$	---	6315	9000	pF
Output Capacitance	C_{oss}		---	220	330	
Reverse Transfer Capacitance	C_{rss}		---	50	100	
Drain-Source Diode Characteristics and Maximum Ratings						
Continuous Source Current	I_S	$V_G=V_D=0V, \text{Force Current}$	---	---	-30	A
Pulsed Source Current	I_{SM}		---	---	-60	A
Diode Forward Voltage	V_{SD}	$V_{GS}=0V, I_S=-1A, T_J=25^{\circ}\text{C}$	---	---	-1	V

Note:

1. Repetitive Rating: Pulsed width limited by maximum junction temperature.
2. $V_{DD}=-50V, V_{GS}=-10V, L=0.1\text{mH}, I_{AS}=-60A, \text{Starting } T_J=25^{\circ}\text{C}$.
3. The data tested by pulsed, pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.
4. Essentially independent of operating temperature.

Typical Electrical and Thermal Characteristic Curves

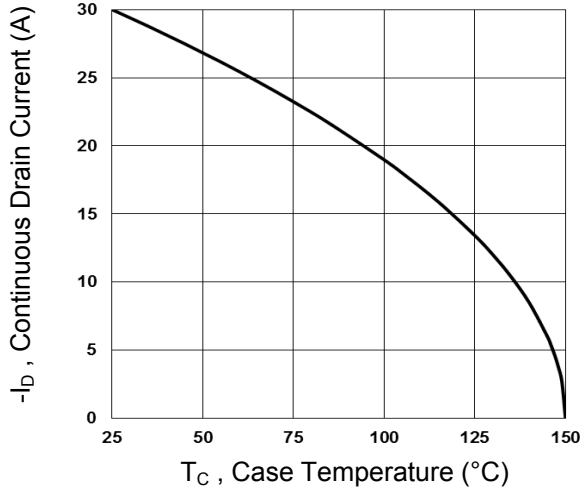


Fig.1 Continuous Drain Current vs. T_c

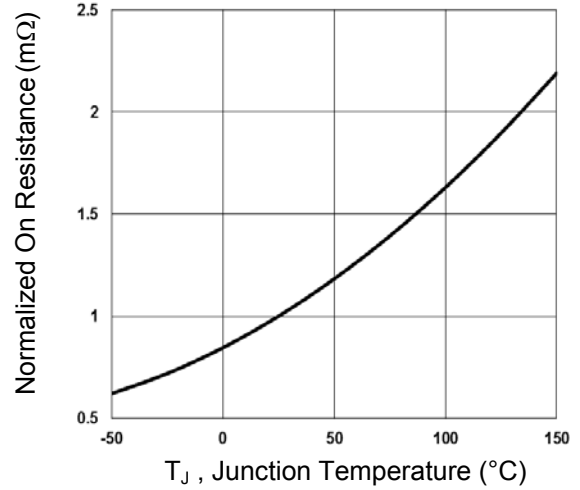


Fig.2 Normalized $R_{DS(ON)}$ vs. T_j

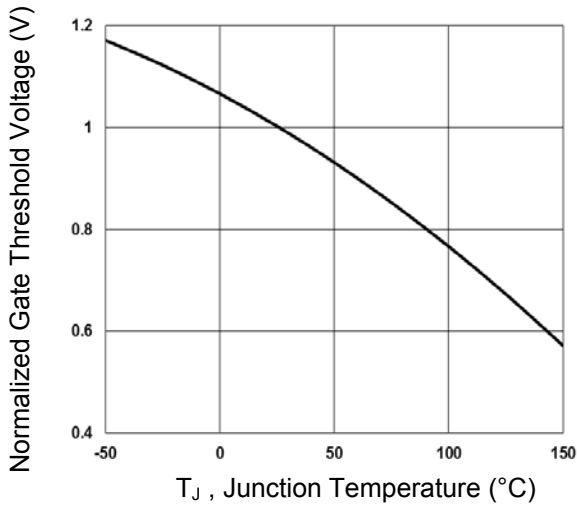


Fig.3 Normalized V_{th} vs. T_j

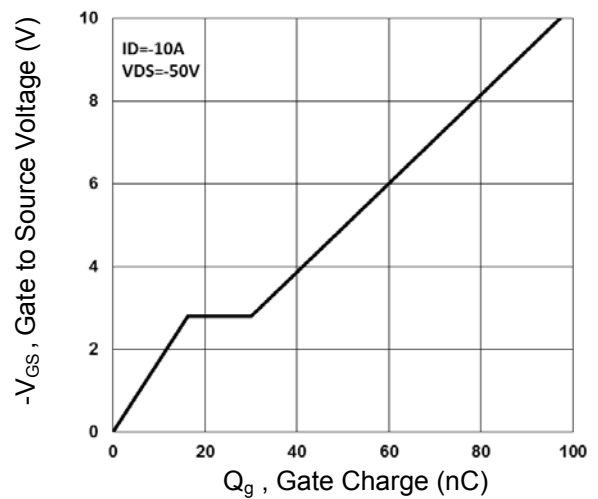


Fig.4 Gate Charge Waveform

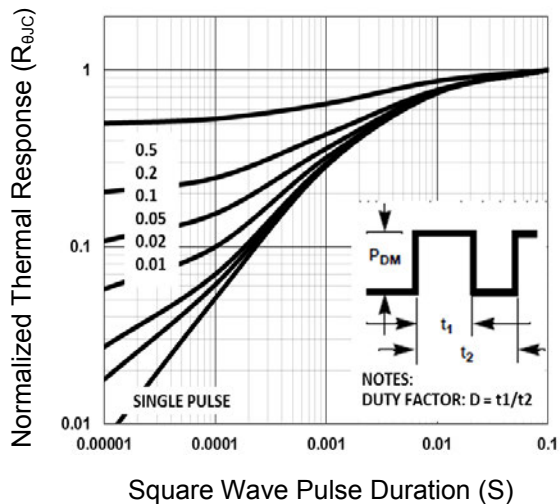


Fig.5 Normalized Transient Impedance

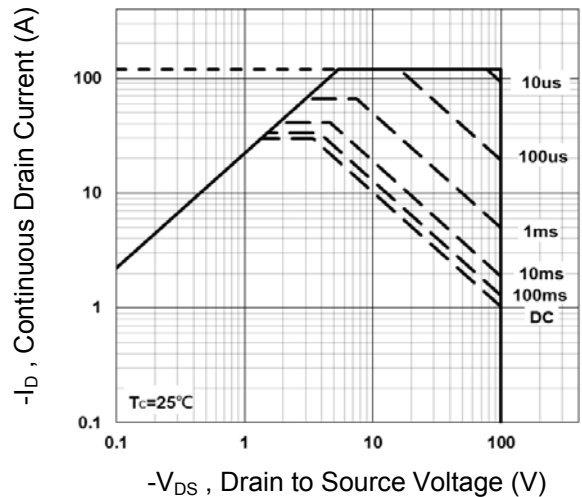


Fig.6 Maximum Safe Operation Area

Typical Electrical and Thermal Characteristic Curves

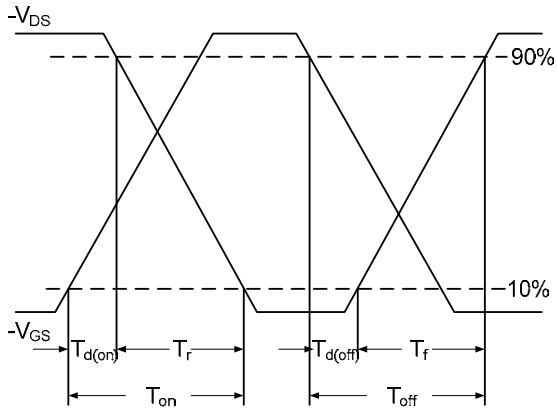


Fig.7 Switching Time Waveform

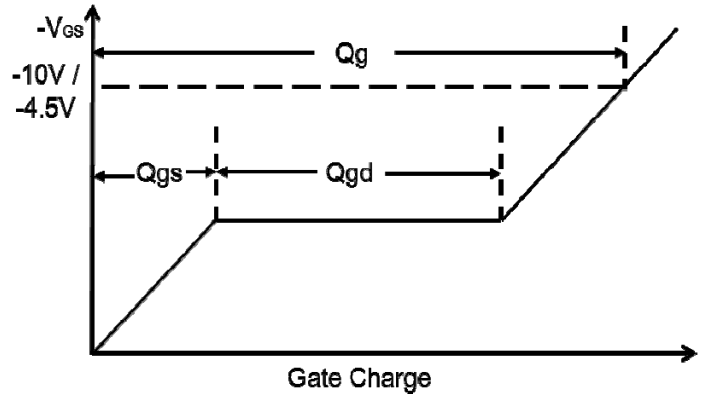


Fig.8 Gate Charge Waveform

